

<b>Search Notes</b>				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/802,784	MARUYAMA ET AL.	
Examiner				Art Unit		
HUY T. NGUYEN				2621		
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
386	46	8/3/06	HW	East search	8/3/06	HW
	95			East Interference Search. See printout	8/19/07	HW
	96			East Interference Search. See printout	11/19/07	HW
	111					
	112					
	120					
	121					
	125					
✓	126	↓	HW			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			
386	95	8/19/07	HW			
Interference Search						
8/19/07 HW						